

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY									
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)						
	0.042 at V _{GS} = 4.5 V	9							
30	0.046 at V _{GS} = 2.5 V	9	5.7 nC						
	0.052 at V _{GS} = 1.8 V	9							

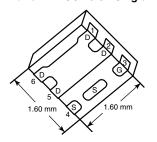
FEATURES

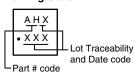
- TrenchFET® Power MOSFET
- 100 % R_a Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

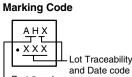


HALOGEN FREE

PowerPAK SC-75-6L-Single

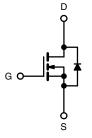






APPLICATIONS

- DC/DC Converters
- **Boost Converters**



N-Channel MOSFET

Ordering Information: SiB410DK-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATIN	13.5 (· A 25 0			1114	
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	30	v		
Gate-Source Voltage	V _{GS}	V _{GS} ± 8			
	T _C = 25 °C		9 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	l _D	9 ^a		
Continuous Diain Current (1) = 130 C)	T _A = 25 °C] 'D	5.9 ^{b, c}		
	T _A = 70 °C	1 [4.7 ^{b, c}	A	
Pulsed Drain Current	I _{DM}	20			
Continuous Source-Drain Diode Current	T _C = 25 °C		9 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is	2.1 ^{b, c}		
	T _C = 25 °C		13		
Maximum Power Discipation	T _C = 70 °C	P _D	8.4	W	
Maximum Power Dissipation	T _A = 25 °C		2.5 ^{b, c}	VV	
	T _A = 70 °C	1 [1.6 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS									
Parameter		Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	41	51	°C/W				
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	7.5	9.5	- C/VV				

- a. Package limited, $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 105 °C/W.



Parameter Symbol Test Conditions Min. Typ. Max. Unit Static	SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)									
Drain-Source Breakdown Voltage V _{DS} V _{GS} = 0 V, I _D = 250 μA 30 I V V V V _{DS} Temperature Coefficient $AV_{DS}IT_{J}$ I _D = 250 μA 31 31 N MV/C MV/C V _{DS} = V _{DS} = 0 V, V _{DS} = 250 μA 0.4 1 V V V SECONDA 0.4 1 V V D 2.50 μA 0.0 1 1 V D 2.0 0.0 1 1 V 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit			
V _{Ds} Temperature Coefficient ΔV _{Ds} (T _D) Temperature Coefficient Δ 1 V Gate-Source Invested Resistance I _{Dss} (T _D) Issue Temperature Coefficient I _{Dss} (T _D) Issue Temperature Coefficient V _{Ds} (T _D) Temperature Coefficient ± 100 n.A Constate Coefficient Coefficient I _{Dss} (T _D) Temperature Coefficient V _{Ds} (T _D) Temperature Coefficient ± 100 n.A Constate Coefficient Coefficient I _{Dss} (T _D) Temperature Coefficient I _{Dss} (T _D) Temperature Coefficient 10 10 n.A Constance Constance Constance Constance Constance Constance Constance Constance Coefficient Coefficient Coefficient I _{Dss} (T _D) Temperature Coefficient <	Static	•								
Vas(m) Temperature Coefficient AVas(m) Vas(m)	Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V			
Vascini, Irriperature Coefficient ΔV _{GS(III)} / V _{DS} = V _{GS, 1} = 250 μA 0.4 1 V Gate-Source Threshold Voltage I _{GSI} V _{DS} = V _{GS, 1} = 250 μA 0.4 1 1 V Zero Gate Voltage Drain Current I _{GSS} V _{DS} = 30 V, V _{GS} = 0 V 1 1 μ On-State Drain Current [®] I _{D(on)} V _{DS} = 30 V, V _{GS} = 0 V 10 1 μ On-State Drain Current [®] I _{D(on)} V _{DS} = 30 V, V _{GS} = 0 V 10 0 A On-State Drain Current [®] I _{D(on)} V _{DS} = 15 V, V _{GS} = 0 V, T _J = 5°C 10 10 A On-State Drain Current [®] I _{D(on)} V _{DS} = 15 V, V _{GS} = 0 V, I = 1 MHz 0.034 0.042 0.041 0.052 D 0.041 0.052 D 0.041 0.052 D D D D D D D D D D D D D D D D D D D D D D D D D D D	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		31		mV/°C			
Case Source Leakage Source Sou	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1D = 230 μΑ		- 2.7					
Variable	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.4		1	V			
Zero Gate Voltage Drain Current Des	Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA			
On-State Drain Current [®] Ib _{O(on)} V _{DS} = 30 V, V _{GS} = 10 V 10 A On-State Drain Current [®] Ib _{O(on)} V _{DS} = 5 V, V _{GS} = 10 V 10	Zone Ooks Walks are Dusin Oromant	lass	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ			
Drain-Source On-State Resistance ^a Position Pos	Zero Gate Voltage Drain Current	DSS	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10				
Drain-Source On-State Resistance and Pasion of Pasion of Pasion Source On-State Resistance and Pasion of Pasion	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	10			Α			
V _{GS} = 1.8 V, I _D = 2 A 0.041 0.052			$V_{GS} = 4.5 \text{ V}, I_D = 3.8 \text{ A}$		0.034	0.042				
Forward Transconductance³ 9ts V _{DS} = 15 V, I _D = 3.8 A 30 S Dynamic¹ Input Capacitance C _{Is8} V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz 60 — pF Reverse Transfer Capacitance C _{rs8} V _{DS} = 15 V, V _{GS} = 8 V, I _D = 3.4 A 10 15 Total Gate Charge Q _g V _{DS} = 15 V, V _{GS} = 8 V, I _D = 3.4 A 10 15 Gate-Source Charge Q _{gs} V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 3.4 A 0.85 — n. Gate-Drain Charge Q _{gs} V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 3.4 A 0.85 — n. Gate Resistance R _g f = 1 MHz 0.6 3 6 Ω Turn-On Delay Time t _d (on) V _{DD} = 15 V, R _L = 4.3 Ω 10 20 40 Fall Time t _L V _{DD} = 15 V, R _L = 4.3 Ω 10 20 40 Turn-Oft Delay Time t _L V _{DD} = 15 V, R _L = 4.3 Ω 10 20 40 Rise Time t _L V _{DD} = 15 V, R _L = 4.3 Ω 10 20 15 10 20 10 <td>Drain-Source On-State Resistance^a</td> <td>R_{DS(on)}</td> <td>$V_{GS} = 2.5 \text{ V}, I_D = 3.6 \text{ A}$</td> <td></td> <td>0.038</td> <td>0.046</td> <td>Ω</td>	Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 3.6 \text{ A}$		0.038	0.046	Ω			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			V _{GS} = 1.8 V, I _D = 2 A		0.041	0.052				
$ \begin{array}{ c c c c c c } \hline \text{Input Capacitance} & C_{\text{iss}} \\ \hline \text{Output Capacitance} & C_{\text{oss}} \\ \hline \text{Output Capacitance} & C_{\text{oss}} \\ \hline \text{Reverse Transfer Capacitance} & C_{\text{rss}} \\ \hline \hline \text{Total Gate Charge} & Q_g \\ \hline \text{Gate-Source Charge} & Q_{\text{gs}} \\ \hline \text{Gate-Drain Charge} & Q_{\text{gs}} \\ \hline \text{Gate-Source Charge} & Q_{\text{gs}} \\ \hline \text{Gate-Drain Diode Current} & Q_{\text{gs}} \\ \hline \text{Is} & Q_{\text{gs} & Q_{\text{gs}} \\ \hline \text{Gate-Drain Charge} & Q_{\text{gs}} \\ \hline \text{Is} & Q_{\text{gs}} & Q_{\text{gs}} \\ \hline \text{Gate-Drain Charge} & Q_{\text{gs}} \\ \hline \text{Is} & Q_{\text{gs}} & Q_{\text{gs}} \\ \hline \text{Gate-Drain Charge} & Q_{\text{gs}} \\ \hline \text{Is} & Q_{\text{gs}} & Q_{\text{gs}}$	Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 3.8 A		30		S			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dynamic ^b	•			•	•				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance	C _{iss}			560					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		60		pF			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance	C _{rss}			27					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Cata Chausa	0	$V_{DS} = 15 \text{ V}, V_{GS} = 8 \text{ V}, I_D = 3.4 \text{ A}$		10	15	nC			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Q_{g}			5.7	8.6				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 3.4 \text{ A}$		0.85					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge	Q _{gd}			0.75					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	-		0.6	3	6	Ω			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			6	12				
	Rise Time	t _r	V_{DD} = 15 V, R_L = 4.3 Ω		10	20				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(off)}	$I_D\cong 3.5$ A, $V_{GEN}=4.5$ V, $R_g=1$ Ω		20	40				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f			10	20				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			5	10	ns			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	V_{DD} = 15 V, R_L = 4.3 Ω		10	20	- - -			
	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 3.5 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		17	30				
	Fall Time	t _f			10	20				
Pulse Diode Forward Current I_{SM} 20 Body Diode Voltage V_{SD} $I_S = 3.5 \text{ A}, V_{GS} = 0 \text{ V}$ 0.8 1.2 V Body Diode Reverse Recovery Time t_{rr} 15 30 ns Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 3.5 \text{ A}, \text{ dl/dt} = 100 \text{ A/µs}, T_J = 25 °C$	Drain-Source Body Diode Characteristic	s			•	•				
Pulse Diode Forward Current I_{SM} 20 Body Diode Voltage V_{SD} $I_S = 3.5 \text{ A}, V_{GS} = 0 \text{ V}$ 0.8 1.2 V Body Diode Reverse Recovery Time t_{rr} 15 30 ns Body Diode Reverse Recovery Charge Q_{rr} $I_F = 3.5 \text{ A}, dI/dt = 100 \text{ A/µs}, T_J = 25 °C$ Reverse Recovery Fall Time t_a $I_F = 3.5 \text{ A}, dI/dt = 100 \text{ A/µs}, T_J = 25 °C$	Continuous Source-Drain Diode Current	Is	T _C = 25 °C			1.5	- A			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Pulse Diode Forward Current	I _{SM}				20				
Body Diode Reverse Recovery Time t_{rr} 1530nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = 3.5 \text{ A}$, $dI/dt = 100 \text{ A/μs}$, $T_J = 25 ^{\circ}\text{C}$ 612nCReverse Recovery Fall Time t_a n_s	Body Diode Voltage		$I_S = 3.5 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V			
Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = 3.5 \text{ A, dI/dt} = 100 \text{ A/µs, T}_J = 25 \text{ °C}$ 8	Body Diode Reverse Recovery Time				15	30	ns			
Reverse Recovery Fall Time t _a I _F = 3.5 A, dl/dt = 100 A/μs, 1 _J = 25 °C 8	Body Diode Reverse Recovery Charge		1 05 A 41/4 100 A/v- T 05 00		6	12	nC			
ns ns	Reverse Recovery Fall Time	1	$I_F = 3.5 \text{ A, al/at} = 100 \text{ A/}\mu\text{s, } I_J = 25 \text{ °C}$		8					
		+			7		ns			

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

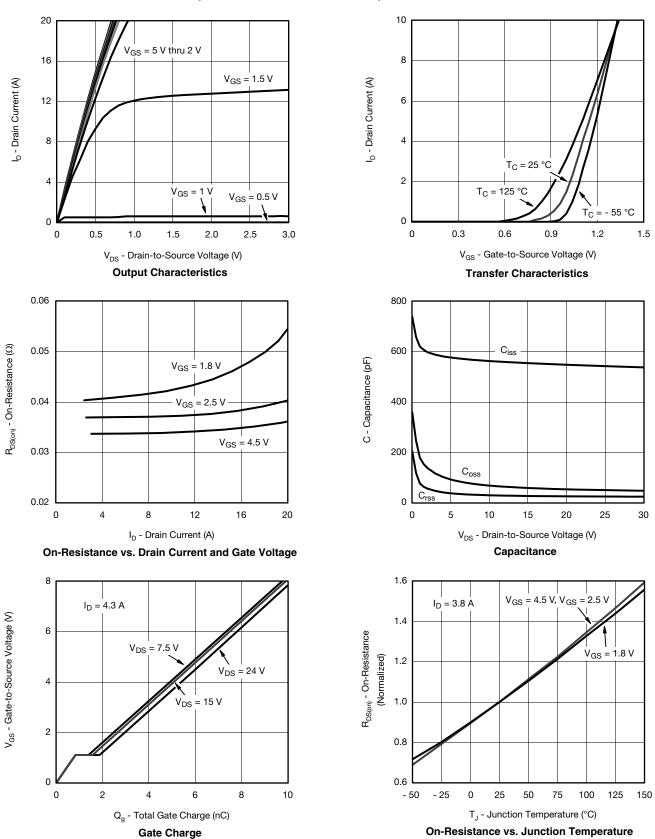
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

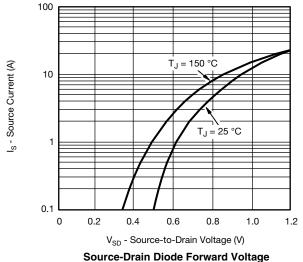


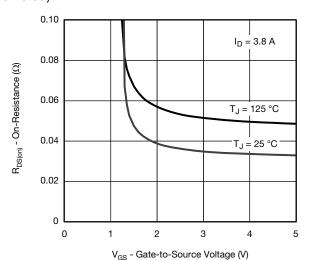


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

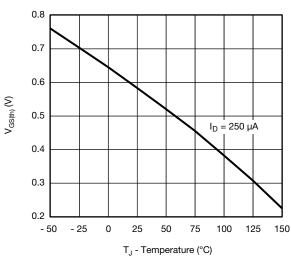


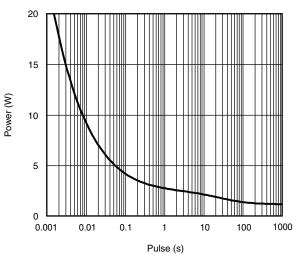
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





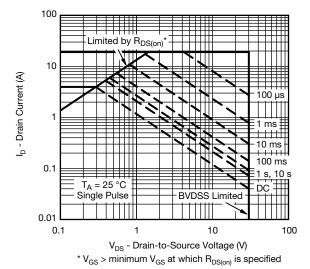
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

Single Pulse Power

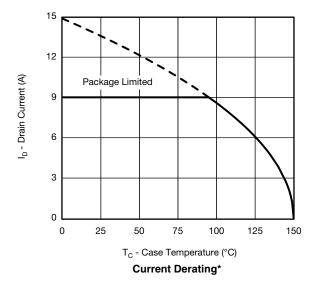


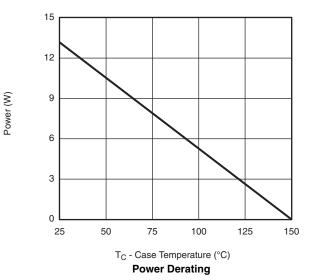
Safe Operating Area, Junction-to-Ambient





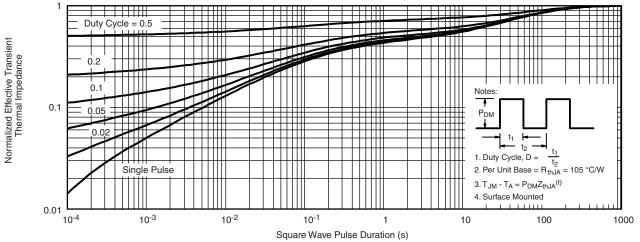
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



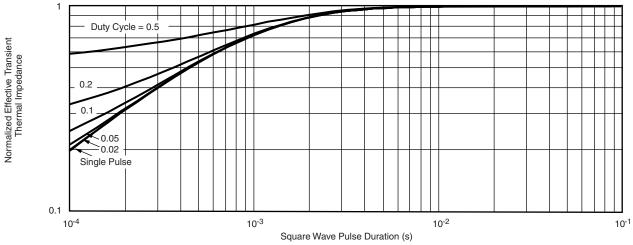


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



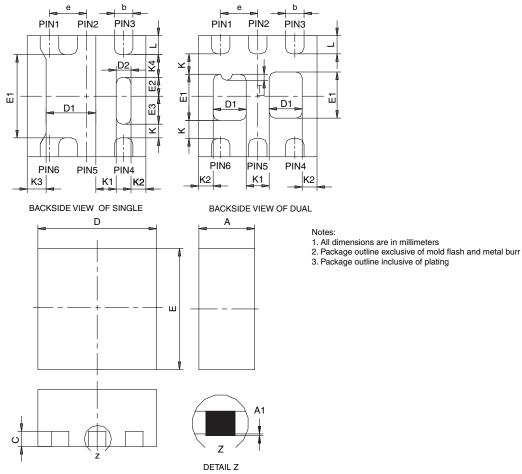
Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?67020.





PowerPAK® SC75-6L



			SINGL	E PAD					DUAI	AL PAD			
DIM	М	ILLIMETER	RS		INCHES		M	ILLIMETER	RS		INCHES		
	Min	Nom	Max	Min	Nom	Max	Min	Nom	Max	Min	Nom	Max	
Α	0.675	0.75	0.80	0.027	0.030	0.032	0.675	0.75	0.80	0.027	0.030	0.032	
A 1	0	-	0.05	0	-	0.002	0	-	0.05	0	-	0.002	
b	0.18	0.25	0.33	0.007	0.010	0.013	0.18	0.25	0.33	0.007	0.010	0.013	
С	0.15	0.20	0.25	0.006	0.008	0.010	0.15	0.20	0.25	0.006	0.008	0.010	
D	1.53	1.60	1.70	0.060	0.063	0.067	1.53	1.60	1.70	0.060	0.063	0.067	
D1	0.57	0.67	0.77	0.022	0.026	0.030	0.34	0.44	0.54	0.013	0.017	0.021	
D2	0.10	0.20	0.30	0.004	0.008	0.012							
E	1.53	1.60	1.70	0.060	0.063	0.067	1.53	1.60	1.70	0.060	0.063	0.067	
E1	1.00	1.10	1.20	0.039	0.043	0.047	0.51	0.61	0.71	0.020	0.024	0.028	
E2	0.20	0.25	0.30	0.008	0.010	0.012							
E3	0.32	0.37	0.42	0.013	0.015	0.017							
е		0.50 BSC			0.020 BSC	;		0.50 BSC			0.020 BSC		
K		0.180 TYP)		0.007 TYP	ı		0.245 TYP			0.010 TYP		
K1		0.275 TYP)		0.011 TYP	ı	0.320 TYP			0.013 TYP			
K2		0.200 TYP)	0.008 TYP			0.200 BSC			0.008 TYP			
К3		0.255 TYP)	0.010 TYP									
K4		0.300 TYP)	0.012 TYP									
L	0.15	0.25	0.35	0.006	0.010	0.014	0.15	0.25	0.35	0.006	0.010	0.014	
Т							0.03	0.08	0.13	0.001	0.003	0.005	

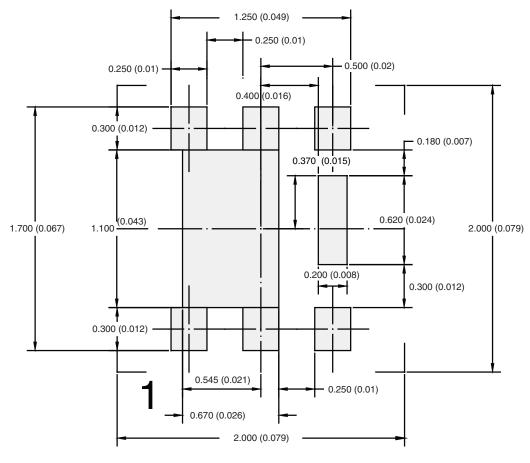
ECN: C-07431 - Rev. C, 06-Aug-07

DWG: 5935

Document Number: 73000 06-Aug-07



RECOMMENDED PAD LAYOUT FOR PowerPAK® SC75-6L Single



Dimensions in mm/(Inches)

Return to Index

ATTLICATION NOT



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

Revision: 13-Jun-16 1 Document Number: 91000

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Vishay:

SIB410DK-T1-GE3